

<b>Notice of References Cited</b>		Application/Control No. 10/001,544	Applicant(s)/Patent Under Reexamination GREIL ET AL.	
		Examiner Mark L. Berch	Art Unit 1624	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,489,470	12-2002	Greil et al.	540/220
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 200134611 A1	05-2001	World Intellect	CHANG et al.	C07D501/36
	O	WO 200109143 A1	02-2001	World Intellect	ARORA et al.	C07D 00/00
	P	JP 03031286 A	02-1991	Japan	HASHIMOTO et al.	C07D501/04
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.